Search Notes	

Application/Control No.	Applicant(s)/Patent und Reexamination	der
10/563,501	HADA ET AL.	
Examiner	Art Unit	
Sin J Lee	1795	

SEARCHED				
Subclass	Date	Examiner		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	· · · · · · · · · · · · · · · · · · ·
	DATE	EXMR
Structure Search for the polymer of CI. #1	1-15 -08	SJL
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